## Notice of References Cited Application/Control No. 10/734,636 Examiner Christopher B. Shin Applicant(s)/Patent Under Reexamination JANG, SEONG-JIN Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,432,735	07-1995	Parks et al.	365/168
*	В	US-6,339,622	01-2002	Kim, Kuy Tae	375/287
*	С	US-4,482,927	11-1984	Melbye et al.	360/40
*	D	US-3,274,611	09-1966	BROWN DAVID T; et. al.	360/40
*	Е	US-4,972,106	11-1990	Ruijs, Jan B. F. W.	326/60
*	F	US-4,506,252	03-1985	Jacoby et al.	341/57
*	G	US-5,045,728	09-1991	Crafts, Harold S.	326/60
*	Н	US-5,498,980	03-1996	Bowles, Gary-Alexander	326/60
*	1	US-5,912,563	06-1999	Garnett, Paul Jeffrey	326/60
*	J	US-5,398,327	03-1995	Yoshida, Yukihiro	710/66
*	К	US-5,287,305	02-1994	Yoshida, Yukihiro	365/189.01
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.